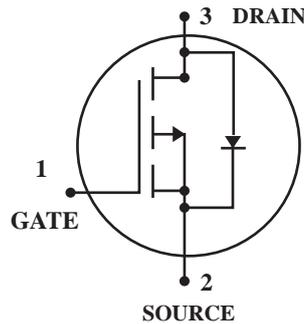


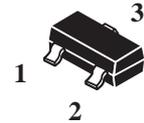
## P-Channel Enhancement Mode Power MOSFET

 Lead(Pb)-Free



**DRAIN CURRENT**  
-4.2 AMPERES

**DRAIN SOURCE VOLTAGE**  
-30 VOLTAGE



**SOT-23**

### Features:

- \*Advanced trench process technology
- \*High Density Cell Design For Ultra Low On-Resistance

### Maximum Ratings ( $T_A=25^\circ\text{C}$ Unless Otherwise Specified)

Rating	Symbol	Value	Unit	
Drain-Source Voltage	$V_{DS}$	-30	V	
Gate-Source Voltage	$V_{GS}$	$\pm 12$		
Continuous Drain Current <sup>1</sup>	$I_D$	( $T_A=25^\circ\text{C}$ )	-4.2	A
		( $T_A=70^\circ\text{C}$ )	-3.5	
Pulsed Drain Current <sup>2</sup>	$I_{DM}$	-30		
Power Dissipation	$P_D$	( $T_A=25^\circ\text{C}$ )	1.4	W
		( $T_A=70^\circ\text{C}$ )	1.0	
Junction and Storage Temperature Range	$T_J, T_{stg}$	-55 ~ +150	$^\circ\text{C}$	

### Thermal Characteristics ( $T_A=25^\circ\text{C}$ Unless Otherwise Specified)

Rating	Symbol	Typ	Max	Unit	
Maximum Junction-to-Ambient <sup>1</sup>	$R_{\theta JA}$	$t \leq 10\text{s}$	65	90	$^\circ\text{C/W}$
		Steady-State	85	125	
Maximum Junction-to-Lead <sup>3</sup>	$R_{\theta JL}$	43	60	$^\circ\text{C/W}$	

1. The value of  $R_{\theta JA}$  is measured with the device mounted on 1in<sup>2</sup> FR-4 board with 2oz. Copper, in a still air environment with  $T_A=25^\circ\text{C}$ . The value in any given application depends on the user's specific board design. The current rating is based on the  $t \leq 10\text{s}$  thermal resistance rating.

2. Repetitive rating, pulse width limited by junction temperature.

3. The  $R_{\theta JA}$  is the sum of the thermal impedance from junction to lead  $R_{\theta JL}$  and lead to ambient.

### Device Marking

WTC3401= A1

## Electrical Characteristics ( $T_A = 25^\circ\text{C}$ Unless otherwise noted)

Characteristic	Symbol	Min	Typ	Max	Units
<b>Static</b>					
Drain-Source Breakdown Voltage $I_D = -250\mu\text{A}, V_{GS} = 0\text{V}$	$BV_{DSS}$	-30			V
Zero Gate Voltage Drain Current $V_{DS} = -24\text{V}, V_{GS} = 0\text{V}$	$I_{DSS}$			-1	$\mu\text{A}$
$T_J = 55^\circ\text{C}$				-5	
Gate-Body leakage current $V_{DS} = 0\text{V}, V_{GS} = \pm 12\text{V}$	$I_{GSS}$			$\pm 100$	nA
Gate Threshold Voltage $V_{DS} = V_{GS}, I_D = -250\mu\text{A}$	$V_{GS(th)}$	-0.7	-1	-1.3	V
On state drain current $V_{GS} = -4.5\text{V}, V_{DS} = -5\text{V}$	$I_{D(ON)}$	-25			A
Static Drain-Source On-Resistance $V_{GS} = -10\text{V}, I_D = -4.2\text{A}$ $V_{GS} = -4.5\text{V}, I_D = -4\text{A}$ $V_{GS} = -2.5\text{V}, I_D = -1\text{A}$	$R_{DS(ON)}$			70	m $\Omega$
				80	
				120	
Forward Transconductance $V_{DS} = -5\text{V}, I_D = -5\text{A}$	$g_{FS}$	7	11		S
Diode Forward Voltage $I_S = -1\text{A}, V_{GS} = 0\text{V}$	$V_{SD}$		-0.75	-1	V
Maximum Body-Diode Continuous Current	$I_S$			-2.2	A
<b>Dynamic</b>					
Input Capacitance $V_{GS} = 0\text{V}, V_{DS} = -15\text{V}, f = 1\text{MHz}$	$C_{iss}$		954		pF
Output Capacitance $V_{GS} = 0\text{V}, V_{DS} = -15\text{V}, f = 1\text{MHz}$	$C_{oss}$		115		pF
Reverse Transfer Capacitance $V_{GS} = 0\text{V}, V_{DS} = -15\text{V}, f = 1\text{MHz}$	$C_{rss}$		77		pF
Gate resistance $V_{GS} = 0\text{V}, V_{DS} = 0\text{V}, f = 1\text{MHz}$	$R_g$		6		$\Omega$
<b>Switching</b>					
Total Gate Charge $V_{GS} = -4.5\text{V}, V_{DS} = -15\text{V}, I_D = -4\text{A}$	$Q_g$		9.4		nC
Gate Source Charge $V_{GS} = -4.5\text{V}, V_{DS} = -15\text{V}, I_D = -4\text{A}$	$Q_{gs}$		2		nC
Gate Drain Charge $V_{GS} = -4.5\text{V}, V_{DS} = -15\text{V}, I_D = -4\text{A}$	$Q_{gd}$		3		nC
Turn-On Delay Time $V_{GS} = -10\text{V}, V_{DS} = -15\text{V}, R_L = 3.6\Omega, R_{GEN} = 6\Omega$	$t_{D(on)}$		6.3		ns
Turn-On Rise Time $V_{GS} = -10\text{V}, V_{DS} = -15\text{V}, R_L = 3.6\Omega, R_{GEN} = 6\Omega$	$t_r$		3.2		ns
Turn-Off Delay Time $V_{GS} = -10\text{V}, V_{DS} = -15\text{V}, R_L = 3.6\Omega, R_{GEN} = 6\Omega$	$t_{D(off)}$		38.2		ns
Turn-Off Fall Time $V_{GS} = -10\text{V}, V_{DS} = -15\text{V}, R_L = 3.6\Omega, R_{GEN} = 6\Omega$	$t_f$		12		ns
Body Diode Reverse Recovery Time $I_F = -4\text{A}, dI/dt = 100\text{A}/\mu\text{s}$	$t_{rr}$		20.2		ns
Body Diode Reverse Recovery Charge $I_F = -4\text{A}, dI/dt = 100\text{A}/\mu\text{s}$	$Q_{rr}$		11.2		nC

## Typical Electrical Characteristics

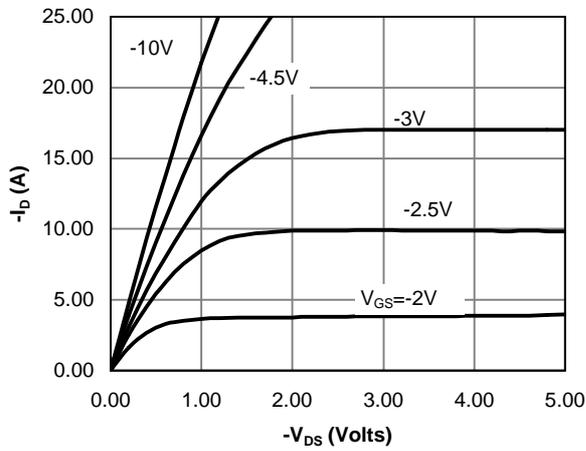


Fig 1: On-Region Characteristics

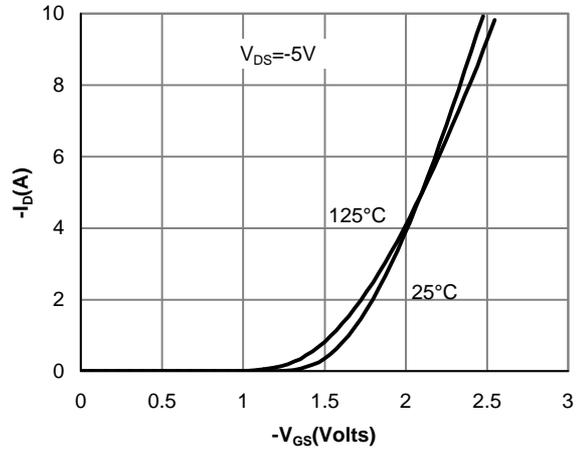


Figure 2: Transfer Characteristics

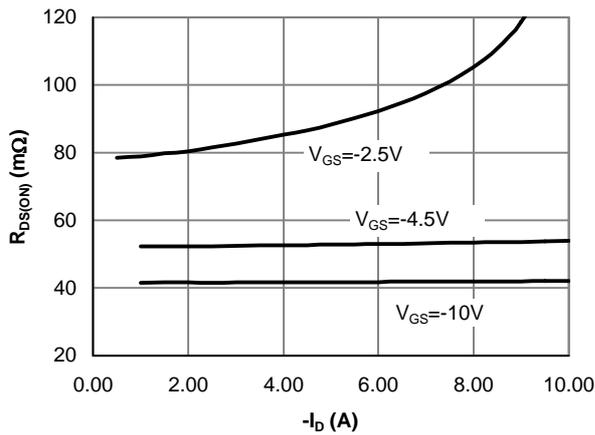


Figure 3: On-Resistance vs. Drain Current and Gate Voltage

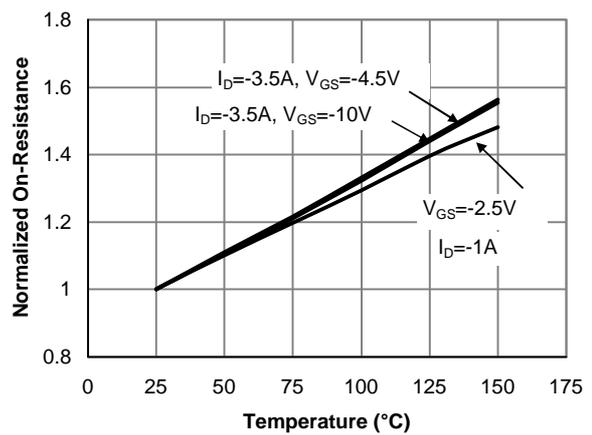


Figure 4: On-Resistance vs. Junction Temperature

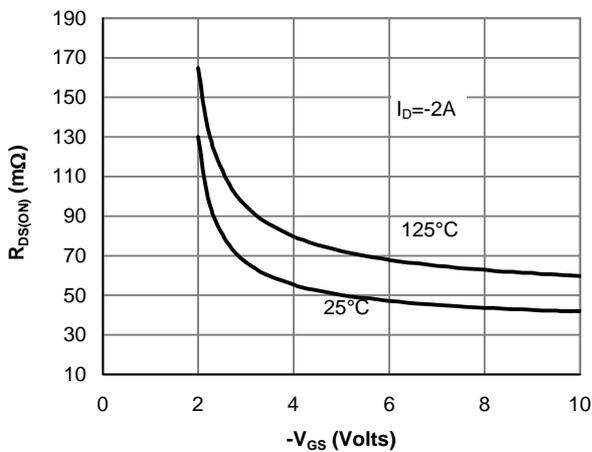


Figure 5: On-Resistance vs. Gate-Source Voltage

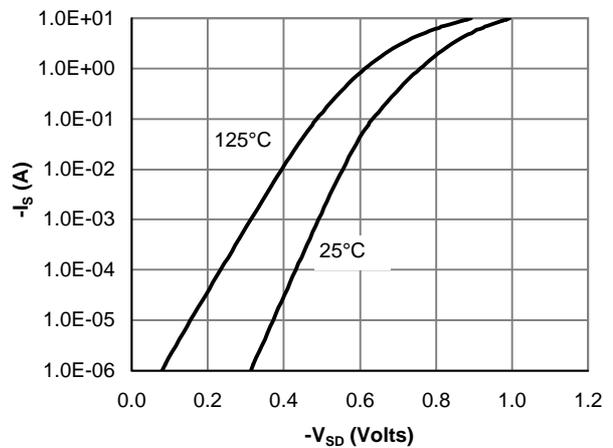


Figure 6: Body-Diode Characteristics

## Typical Electrical Characteristics

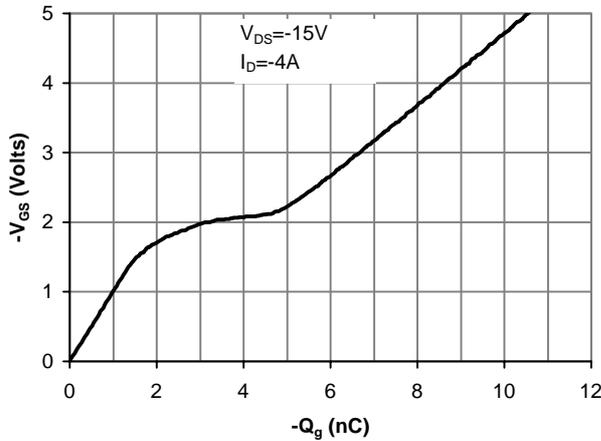


Figure 7: Gate-Charge Characteristics

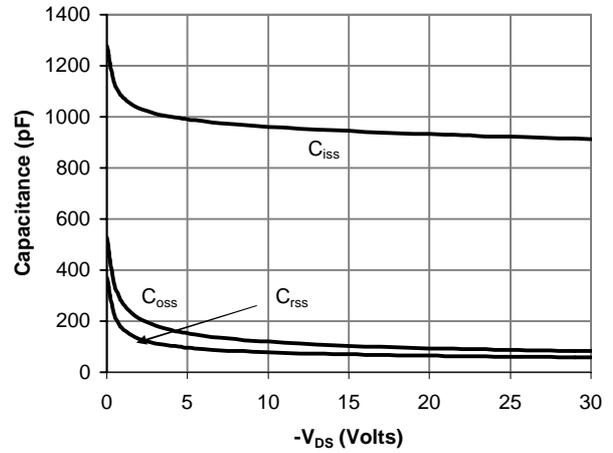


Figure 8: Capacitance Characteristics

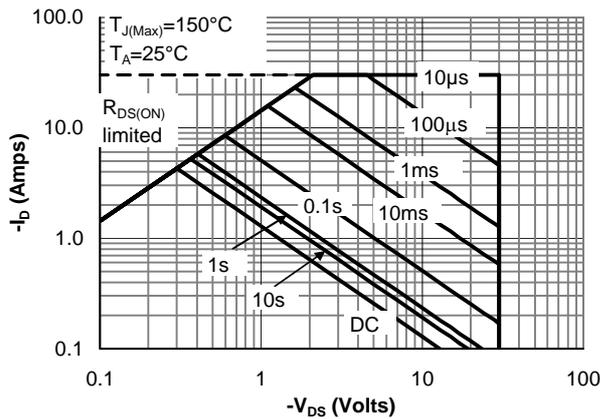


Figure 9: Maximum Forward Biased Safe Operating Area (Note E)

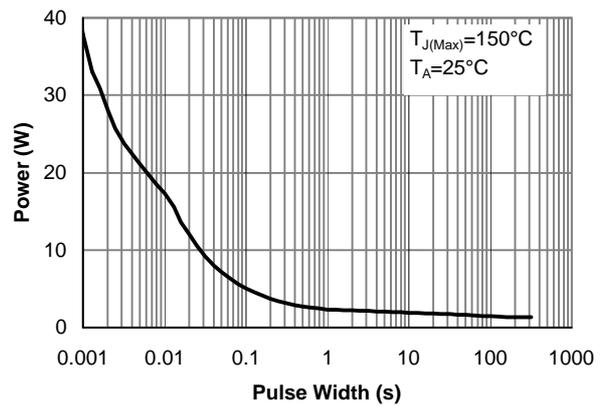


Figure 10: Single Pulse Power Rating Junction-to-Ambient (Note E)

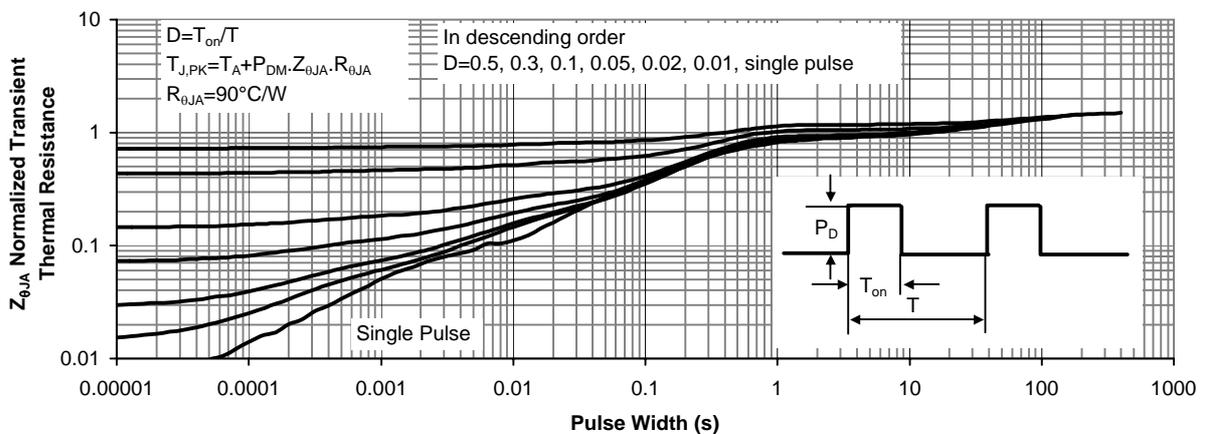
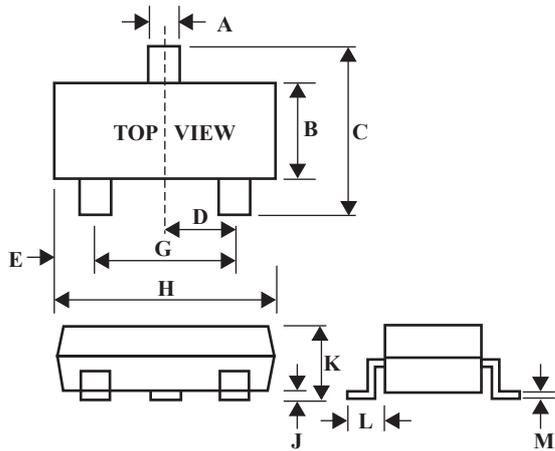


Figure 11: Normalized Maximum Transient Thermal Impedance

**SOT-23 Outline Dimension**



<b>SOT-23</b>		
<b>Dim</b>	<b>Min</b>	<b>Max</b>
<b>A</b>	0.35	0.51
<b>B</b>	1.19	1.40
<b>C</b>	2.10	3.00
<b>D</b>	0.85	1.05
<b>E</b>	0.46	1.00
<b>G</b>	1.70	2.10
<b>H</b>	2.70	3.10
<b>J</b>	0.01	0.13
<b>K</b>	0.89	1.10
<b>L</b>	0.30	0.61
<b>M</b>	0.076	0.25